

Search Notes**Application/Control No.**

10/721,389

Examiner

Duy M. Dang

Applicant(s)/Patent under Reexamination

HATANAKA ET AL.

Art Unit

2624

SEARCHED

Class	Subclass	Date	Examiner
382	232-239 244 246	5/30/2007	DD
348	397.1		
	407.1		
	620		
375	240		
	240.1		
358	1.15		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East (uspto, derwent, jpo, epo), see printouts	5/30/07 6/6/07	DuyD
Inventor search (east) see printouts	✓	✓